# **4 A Single Load Switch for Low Voltage Rail**

The NCV459 is a power load switch with very low Ron NMOSFET controlled by external logic pin, allowing optimization of battery life, and portable device autonomy.

Indeed, thanks to a best in class current consumption optimization with NMOS structure, leakage currents are drastically decreased. Offering optimized leakages isolation on the ICs connected on the battery.

Output discharge path is proposed to eliminate residual voltages on the external components connected on output pin.

Proposed in wide input voltage range from 0.75 V to 5.5 V, and a very small DFNW8 3x3 mm, 0.65 pitch package.

#### **Features**

- 0.75 V 5.5 V Operating Range
- 23 mΩ N-MOSFET
- Vbias Rail Input
- DC Current up to 4 A
- Output Auto-Discharge Option
- Active High EN Pin
- DFNW8, 3 x 3 mm, 0.65 pitch

### **Typical Applications**

- ADAS System
- Camera Module
- Power Management



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## **MARKING** DIAGRAM



#### DFNW8 CASE 507AB

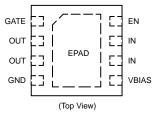


= Specific Device Code 45A Α = Assembly Location

= Wafer Lot L Υ = Year W = Work Week = Pb-Free Package

(Note: Microdot may be in either location)

#### PINOUT DIAGRAM



#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 10 of this data sheet.

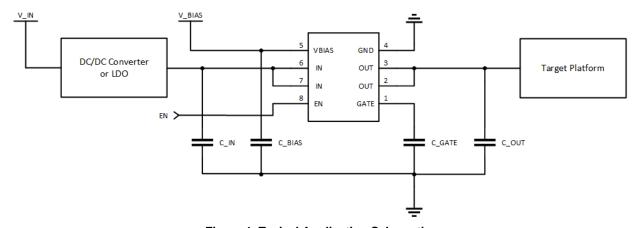


Figure 1. Typical Application Schematic

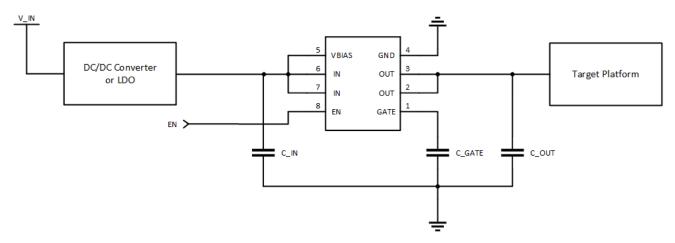


Figure 2. Application Schematic with Vbias Connected to IN

# PIN FUNCTION DESCRIPTION

Pin Name	Pin Number	Туре	Description	
GATE	1	INPUT	OUT pin slew rate control (t <sub>rise</sub> ).	
OUT	2, 3	POWER	Load-switch output pin.	
GND	4	POWER	Ground connection.	
VBIAS	5	POWER	External supply voltage input.	
IN	6, 7	POWER	Load-switch input pin.	
EN	8	INPUT	Enable input, logic high turns on power switch.	
EPAD	9	POWER	Exposed pad, connect to ground potential.	

# **BLOCK DIAGRAMS**

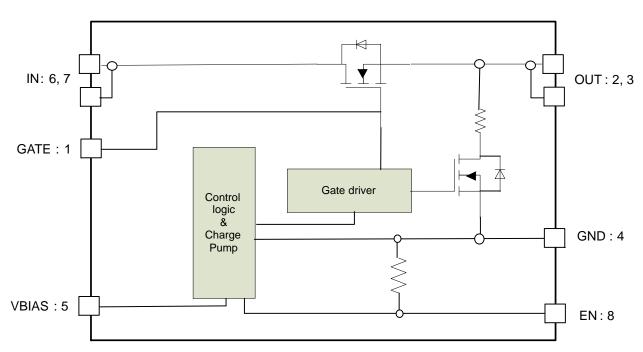


Figure 3. NCV459 Block Diagram

#### **MAXIMUM RATINGS**

Rating	Symbol	Value	Unit
IN, OUT, EN, VBIAS, GATE Pins: (Note 1)	V <sub>EN</sub> , V <sub>IN</sub> , V <sub>OUT</sub> , V <sub>BIAS</sub> , V <sub>GATE</sub>	-0.3 to +6.5	V
From IN to OUT Pins: Input/Output (Note 1)	V <sub>IN</sub> , V <sub>OUT</sub>	0 to + 6.5	V
Human Body Model (HBM) ESD Rating are (Note 2)	ESD HBM	2000	V
Maximum Junction Temperature	TJ	-40 to + 125	°C
Storage Temperature Range	T <sub>STG</sub>	-40 to + 150	°C
Moisture Sensitivity (Note 3)	MSL	Level 1	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. According to JEDEC standard JESD22-A108.
- 2. This device series contains ESD protection and passes the following tests: Human Body Model (HBM) ±2.0 kV per JEDEC standard: JESD22-A114 for all pins.
- 3. Moisture Sensitivity Level (MSL): 1 per IPC/JEDEC standard: J-STD-020.

#### **OPERATING CONDITIONS**

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V <sub>IN</sub>	Operational Power Supply		0.75		5.5	V
V <sub>EN</sub>	Enable Voltage		0		5.5	V
V <sub>BIAS</sub>	Bias voltage (V <sub>BIAS</sub> ≥ best of V <sub>IN</sub> , V <sub>OUT</sub> )		1.2		5.5	V
T <sub>A</sub>	Ambient Temperature Range		-40	25	+105	°C
C <sub>IN</sub>	Decoupling input capacitor		100			nF
C <sub>OUT</sub>	Decoupling output capacitor		100			nF
$R_{\theta JA}$	Thermal Resistance Junction to Air	DFNW8 (Note 4)		106		°C/W
l <sub>OUT</sub>	DC current			4	4.5	Α
	AC current 1 ms @ 217 Hz				5	Α
	AC current 100 μs spike				15	Α
P <sub>D</sub>	Power Dissipation Rating (Note 5)			0.18		W

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

- 4. Value based on 1s0p board with copper 650 mm² (or 1 in²) of 1 oz thickness and FR4 PCB substrate
   5. The maximum power dissipation (PD) is given by the following formula:

$$P_D = \frac{T_{JMAX} - T_A}{R_{\theta JA}}$$

**ELECTRICAL CHARACTERISTICS** Min & Max Limits apply for  $T_J$  between  $-40^{\circ}C$  to  $+125^{\circ}C$  for  $V_{IN}$  between 0.75 V and 5.5 V, and  $V_{BIAS}$  between 1.2 V and 5.5 V (Unless otherwise noted). Typical values are referenced to  $T_A = +25^{\circ}C$ ,  $V_{IN} = 3.3$  V and  $V_{BIAS} = 5$  V (Unless otherwise noted).

Symbol	Parameter	Conditions			Тур	Max	Unit
POWER S	WITCH				•	•	
		V V 55V	I <sub>OUT</sub> = 200 mA, T <sub>A</sub> = 25°C		23	60	
		$V_{IN} = V_{BIAS} = 5.5 \text{ V}$	T <sub>J</sub> = 125°C			80	1
		., .,	I <sub>OUT</sub> = 200 mA, T <sub>A</sub> = 25°C		23	60	- - -
		$V_{IN} = V_{BIAS} = 3.3 \text{ V}$	T <sub>J</sub> = 125°C			80	
		V <sub>IN</sub> = V <sub>BIAS</sub> = 1.8 V	I <sub>OUT</sub> = 200 mA, T <sub>A</sub> = 25°C		23	60	
			T <sub>J</sub> = 125°C			80	
Б	Static drain-source	V V 45V	$I_{OUT} = 200 \text{ mA}, T_A = 25^{\circ}\text{C}$		23	60	mΩ
R <sub>DS(on)</sub>	on-state resistance for each rail	$V_{IN} = V_{BIAS} = 1.5 V$	T <sub>J</sub> = 125°C			80	
		V V 40V	$I_{OUT} = 200 \text{ mA}, T_A = 25^{\circ}\text{C}$		24	60	
		$V_{IN} = V_{BIAS} = 1.2 \text{ V}$	T <sub>J</sub> = 125°C			80	- - - -
		V <sub>IN</sub> = 1.0 V	$I_{OUT} = 200 \text{ mA}, T_A = 25^{\circ}\text{C}$		24	60	
		V <sub>BIAS</sub> = 1.2 V	T <sub>J</sub> = 125°C			80	
		V <sub>IN</sub> = 0.8 V V <sub>BIAS</sub> = 1.2 V	I <sub>OUT</sub> = 200 mA, T <sub>A</sub> = 25°C		24	60	
			T <sub>J</sub> = 125°C			80	
R <sub>DIS</sub>	Output discharge path		EN = low		230	300	Ω
TIMINGS (	Note 6)			•	•	•	•
	Output rise time From 10% to 90% of V <sub>OUT</sub>	V <sub>IN</sub> = 5 V C <sub>LOAD</sub> = 1 μF,	No cap on GATE pin		0.26		ms
$T_{R}$			Gate capacitor = 1 nF		1.5		
			Gate capacitor = 10 nF		15		
_	Enable time From En V <sub>ih</sub>		Without Cgate		10		μS
T <sub>en</sub>	to 10% of V <sub>OUT</sub>	$R_{LOAD} = 25 \Omega$	With 1 nF on Gate		60		μs
T <sub>F</sub>	Fall Time. From 90% to 10% of V <sub>OUT</sub>				50		μS
Tdis	Disable time	1	From EN to 90% Vout		75		μs
			No cap on GATE pin		0.25	0.5	
$T_{R}$	Output rise time From 10% to 90% of V <sub>OUT</sub>		Gate capacitor = 1 nF		1		ms
		V <sub>IN</sub> = 3.3 V	Gate capacitor = 10 nF		10		
_	Enable time	$C_{LOAD} = 1 \mu F$	Without Cgate		20	50	μS
T <sub>en</sub>	From En V <sub>ih</sub> to 10% of V <sub>OUT</sub>	$R_{LOAD} = 25 \Omega$	With 1 nF on Gate		114		μS
$T_F$	Output fall time From 90% to 10% of V <sub>OUT</sub>				60	120	μS
T <sub>R</sub>			No cap on GATE pin		0.12		
	Output rise time From 10% to 90% of V <sub>OUT</sub>		Gate capacitor = 1 nF		0.6		ms
		$V_{IN}$ = 1.8 V $C_{LOAD}$ = 1 μF, $R_{LOAD}$ = 25 $\Omega$	Gate capacitor = 10 nF		5.5		1
т	Enable time From En V <sub>ih</sub>		Without Cgate		15		μs
T <sub>en</sub>	to 10% of V <sub>OUT</sub>		With 1 nF on Gate		85		μs
T <sub>F</sub>	Output fall time From 90% to 10% of V <sub>OUT</sub>				35		μS
		1	1				

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

<sup>6.</sup> Parameters are guaranteed for C<sub>LOAD</sub> and R<sub>LOAD</sub> connected to the OUT pin with respect to the ground

**ELECTRICAL CHARACTERISTICS** Min & Max Limits apply for  $T_J$  between  $-40^{\circ}C$  to  $+125^{\circ}C$  for  $V_{IN}$  between 0.75 V and 5.5 V, and  $V_{BIAS}$  between 1.2 V and 5.5 V (Unless otherwise noted). Typical values are referenced to  $T_A = +25^{\circ}C$ ,  $V_{IN} = 3.3$  V and  $V_{BIAS} = 5$  V (Unless otherwise noted).

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
TIMINGS (1	Note 6)						-
		$V_{IN} = 1 \text{ V}$ $C_{LOAD} = 1  \mu\text{F},$ $R_{LOAD} = 25  \Omega$	No cap on GATE pin		0.01		ms
$T_R$	Output rise time From 10% to 90% of V <sub>OUT</sub>		Gate capacitor = 1 nF		1		
	1 10111 1070 to 3070 of \$000		Gate capacitor = 10 nF		13		1
т	Enable time From En V <sub>ih</sub>	V <sub>IN</sub> = 1 V	Without Cgate		10		μs
T <sub>en</sub>	to 10% of V <sub>OUT</sub>	$C_{LOAD} = 1 \mu F$	With 1 nF on Gate		0.4		ms
T <sub>F</sub>	Output fall time	$R_{LOAD} = 25 \Omega$			20		μs
Logic							
$V_{IH}$	High-level input voltage			0.9			V
$V_{IL}$	Low-level input voltage					0.4	V
R <sub>EN</sub>	Pull down resistor			3		7	МΩ
QUIESCEN	IT CURRENT						
I <sub>VBIAS</sub>	V <sub>BIAS</sub> Quiescent current	$V_{BIAS} = 3.3 \text{ V}, EN = \text{high}$			1.3	5	μΑ
I <sub>INQ</sub>	IN Quiescent current	EN = high			0.01	0.3	μΑ
I <sub>STBIN</sub>	Standby current IN	EN = low, IN standby current, $V_{IN}$ = 3.3 V, with discharge path, $T_A$ = $-40^{\circ}$ C to $85^{\circ}$ C			0.01	0.5	μΑ
STDVbias	Standby current V <sub>BIAS</sub>	$V_{BIAS} = 3.3 \text{ V EN} = \text{low}, T_A = -40^{\circ}\text{C to } 85^{\circ}\text{C}$			0.4	1.5	μΑ

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

6. Parameters are guaranteed for C<sub>LOAD</sub> and R<sub>LOAD</sub> connected to the OUT pin with respect to the ground

# **TIMINGS**

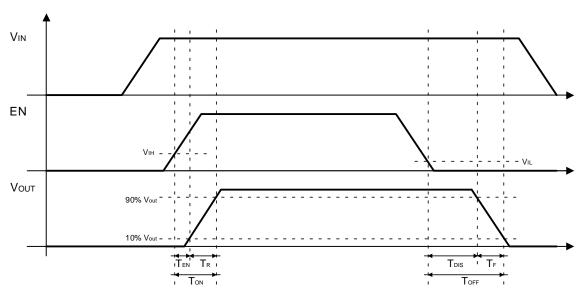
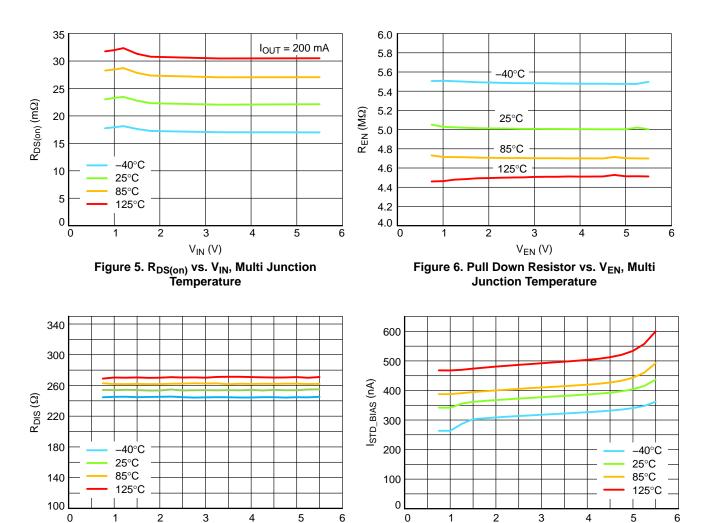


Figure 4. Enable, Rise and Fall Time

# **TYPICAL CHARACTERISTICS**



 $\begin{aligned} & \mathsf{V_{IN}} \; (\mathsf{V}) \\ \text{Figure 7. Output Discharge Resistor vs. } \mathbf{V_{IN}}, \\ & \mathbf{Multi Junction Temperature} \end{aligned}$ 

Figure 8. BIAS Standby Current vs. V<sub>BIAS</sub>, Multi Junction Temperature

 $V_{\mathsf{BIAS}}\left(V\right)$ 

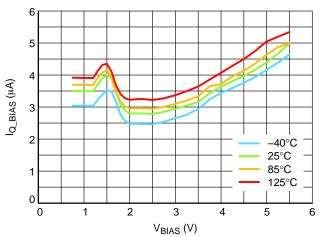


Figure 9. BIAS Quiescent Current vs. V<sub>BIAS</sub>, Multi Junction Temperature

# TYPICAL CHARACTERISTICS

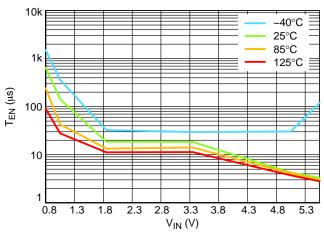


Figure 10. Enable Time vs. V<sub>IN</sub>, Multi Junction Temperature (without Cgate)

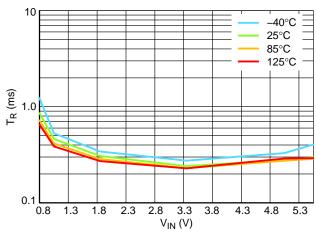


Figure 11. Rise Time vs. V<sub>IN</sub>, Multi Junction Temperature (without Cgate)

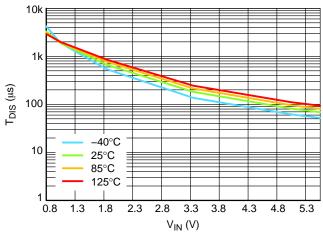


Figure 12. Disable Time vs.  $V_{\text{IN}}$ , Multi Junction Temperature,  $V_{\text{BIAS}}$  and  $V_{\text{IN}}$  Tied Together

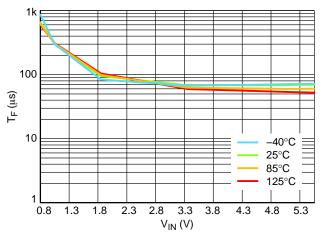


Figure 13. Fall Time vs. V<sub>IN</sub>, Multi Junction Temperature, V<sub>BIAS</sub> and V<sub>IN</sub> Tied Together R<sub>load</sub> 25  $\Omega$ 

### **FUNCTIONAL DESCRIPTION**

#### Overview

The NCV459 are high side N channel MOSFET power distribution switch designed to isolate ICs connected on the LDO or DCDC supplies in order to save energy. The part can be used with a wide range of supply from 0.75 V to 5.5 V.

#### **Enable Input**

Enable pin is an active high. The path is opened when EN pin is tied low (disable), forcing NMOS switch off.

The IN/OUT path is activated with a minimum of  $V_{BIAS}$  min, Vin min and EN forced to high level.

### **Auto Discharge**

NMOS FET is placed between the output pin and GND, in order to discharge the application capacitor connected on OUT pin.

The auto-discharge is activated when EN pin is set to low level (disable state).

The discharge path (Pull down NMOS) stays activated as long as EN pin is set at low level.

In order to limit the current across the internal discharge Nmosfet, the typical value is set at R<sub>DIS</sub> value.

#### **Vbias Rail**

The core of the IC is supplied thanks to Vbias supply rail (common +5 V, 3.3 V, 1.8 V, 1.2 V). Indeed, no current

consumption is used on IN pin, allowing to improve power saving of the rail that must be isolated by the power switch.

If Vbias rail is not available or used, Vbias pin and Vin pin can be connected together as close as possible the DUT. A minimum of 1.2 V is necessary to control the IC. It is recommended to connect external capacitor 10  $\mu F$  due to better EMC immunity.

### Output rise time - Gate control

The NMOS is control with internal charge pump and driver. A minimum gate slew rate is internally set to avoid huge inrush current when EN is set from low to high. The default gate slew rate depends on Vin level. The higher Vin level, the longer rise time.

In addition, an external capacitor can be connected between Gate pin and GND in order to slow down the gate rising. See electrical table for more details.

### **Cin and Cout Capacitors**

100~nF external capacitors must be connected as close as possible the DUT for noise immunity and better stability. In case of input hot plug (input voltage connected with fast slew rate – few  $\mu s$  – it's strongly recommended to avoid big capacitor connected on the input. That allows to avoid input over voltage transients.

# **APPLICATION INFORMATION**

# **Power Dissipation**

Main contributor in term of junction temperature is the power dissipation of the power MOSFET. Assuming this, the power dissipation and the junction temperature in normal mode can be calculated with the following equations:

$$P_D = R_{DS(on)} \times (I_{OUT})^2$$
 (eq. 1)

 $P_D$  = Power dissipation (W)

 $R_{DS(on)}$  = Power MOSFET on resistance ( $\Omega$ )

 $I_{OUT}$  = Output current (A)

 $T_J = P_D \times R_{\theta JA} + T_A$  (eq. 2)

 $T_J$  = Junction temperature (°C

 $R_{\theta JA}$  = Package thermal resistance (°C/W)

 $T_A$  = Ambient temperature (°C)

# **ORDERING INFORMATION**

Device	Marking	Option	Package	Shipping <sup>†</sup>
NCV459NMWTBG	45A	Auto Discharge 230 $\Omega$	DFNW8 3 x 3 mm (Pb-Free)	3000 / Tape & Reel

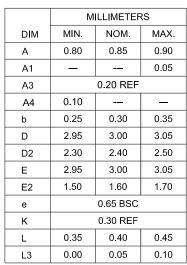
<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

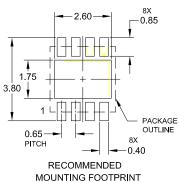
# DFNW8 3x3, 0.65P CASE 507AB ISSUE E SCALE 2:1

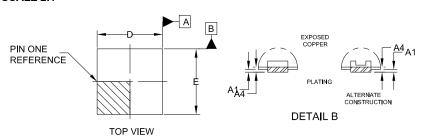
DATE 02 JUL 2021

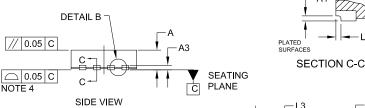
#### NOTES:

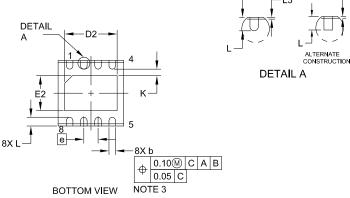
- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- DIMENSION & APPLIES TO PLATED
   TERMINALS AND IS MEASURED BETWEEN
   0.15 AND 0.30MM FROM THE TERMINAL TIP.
- 4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.
- 5. THIS DEVICE CONTAINS WETTABLE FLANK
  DESIGN FEATURES TO AID IN FILLET
  FORMATION ON THE LEADS DURING MOUNTING.











# GENERIC MARKING DIAGRAM\*



XXXXXX = Specific Device Code

A = Assembly Location

L = Wafer Lot

Y = Year

W = Work Week

= Pb-Free Package

(Note: Microdot may be in either location)

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " =", may or may not be present. Some products may not follow the Generic Marking.

g.								
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DESCRIPTION:	DFNW8 3x3, 0.65P		PAGE 1 OF 1					

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